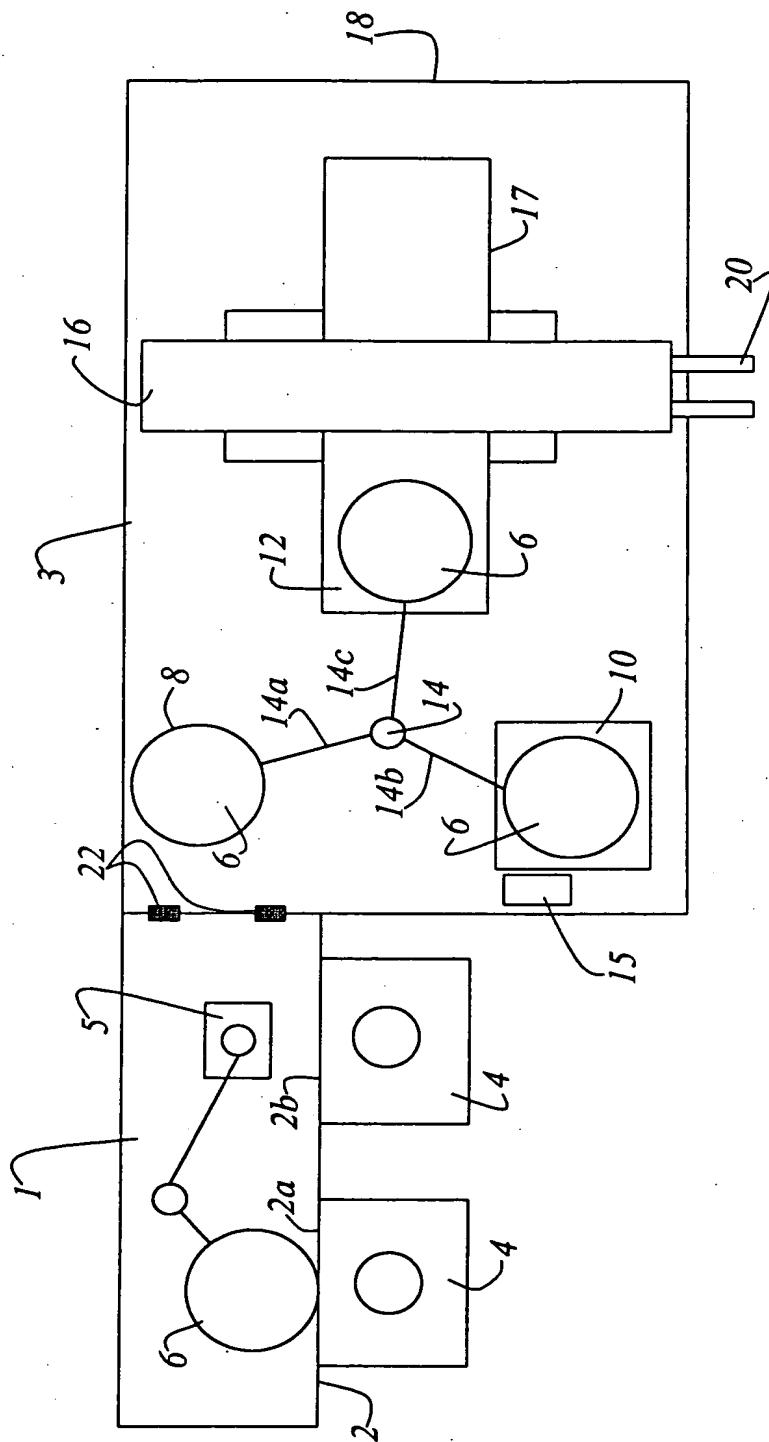


Title: METHOD AND ARRANGEMENT  
FOR TRANSPORTING AND INSPECTING  
SEMICONDUCTOR SUBSTRATES  
Inventor(s): Andreas BIRKNER et al.  
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1  
Fig.

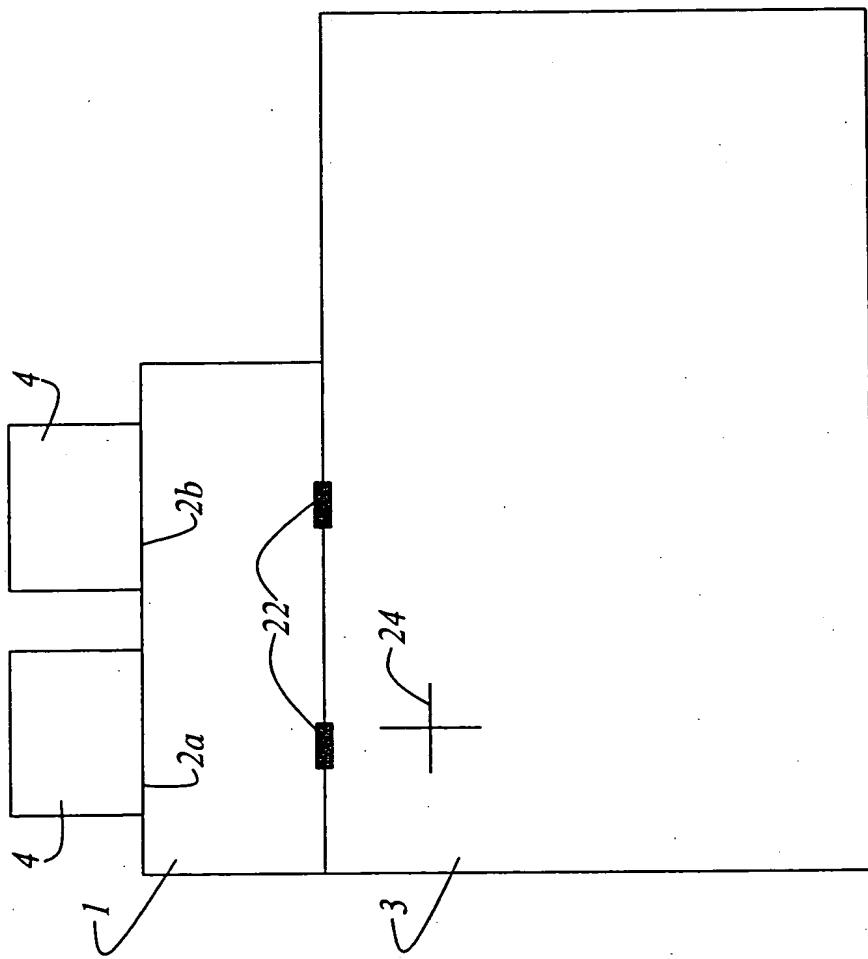


Fig. 2

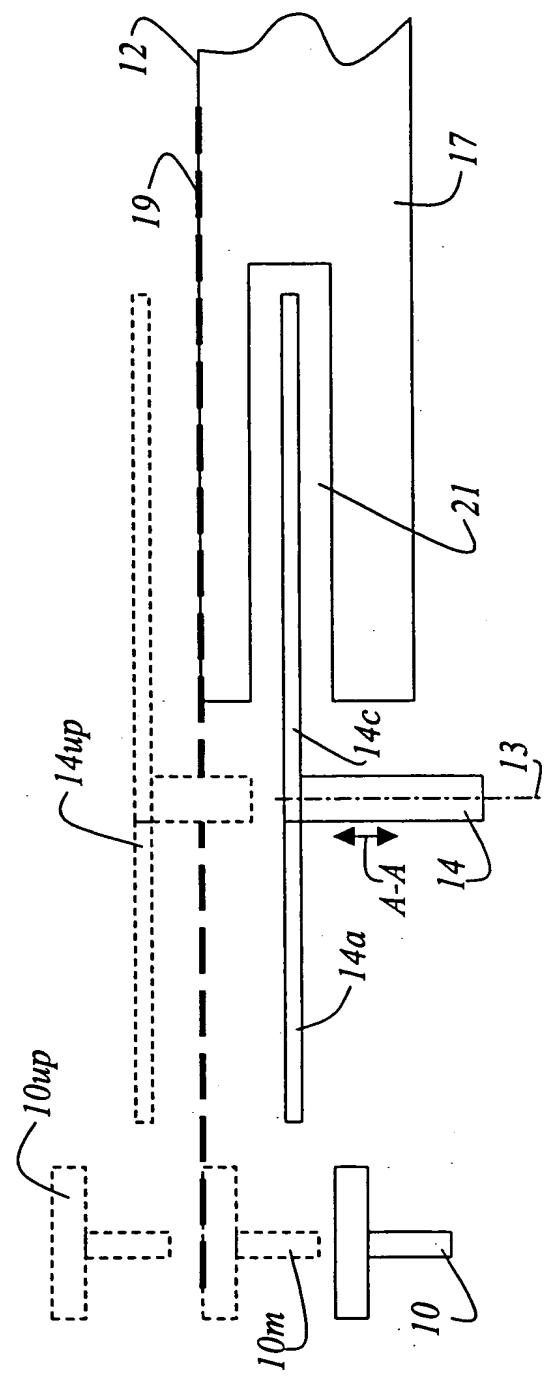


Fig. 3

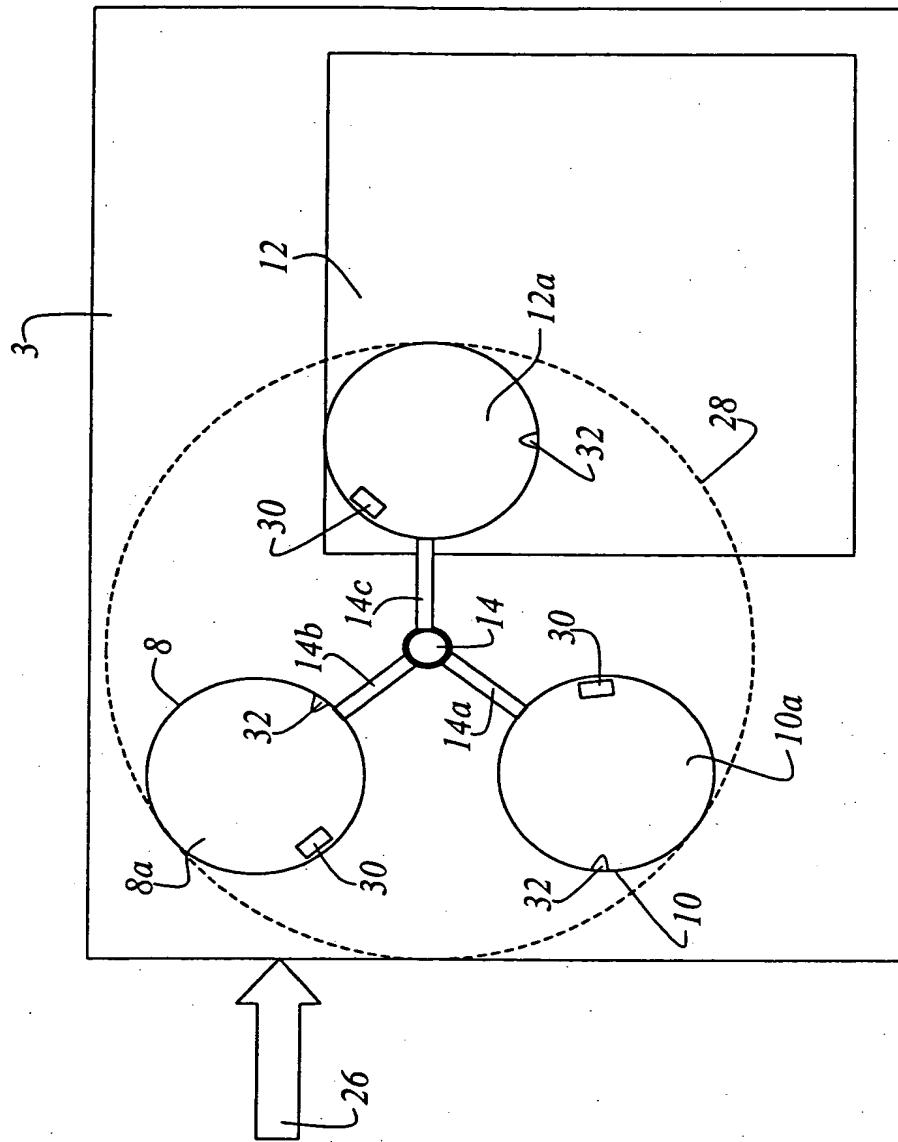


Fig. 4

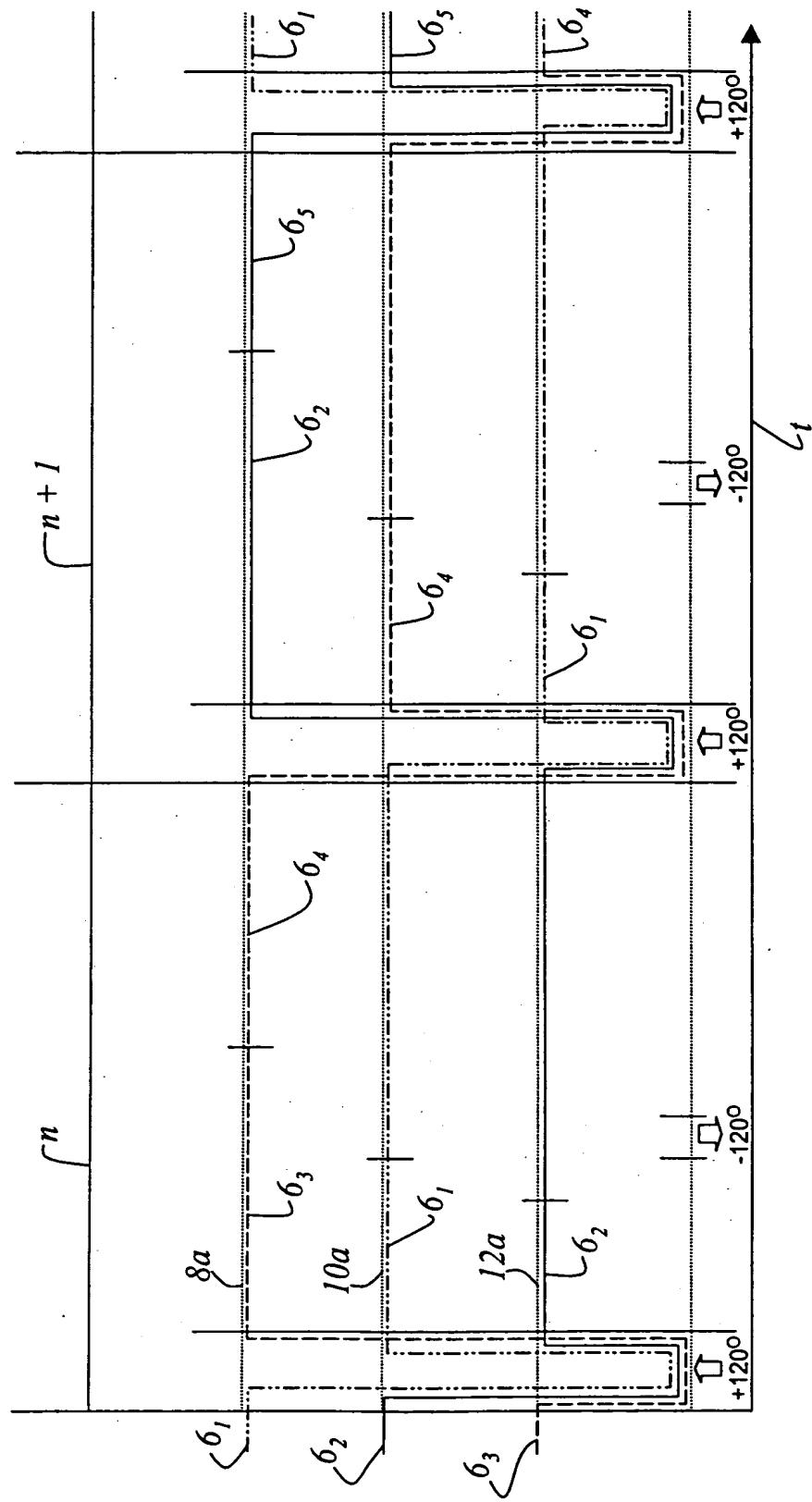


Fig. 5

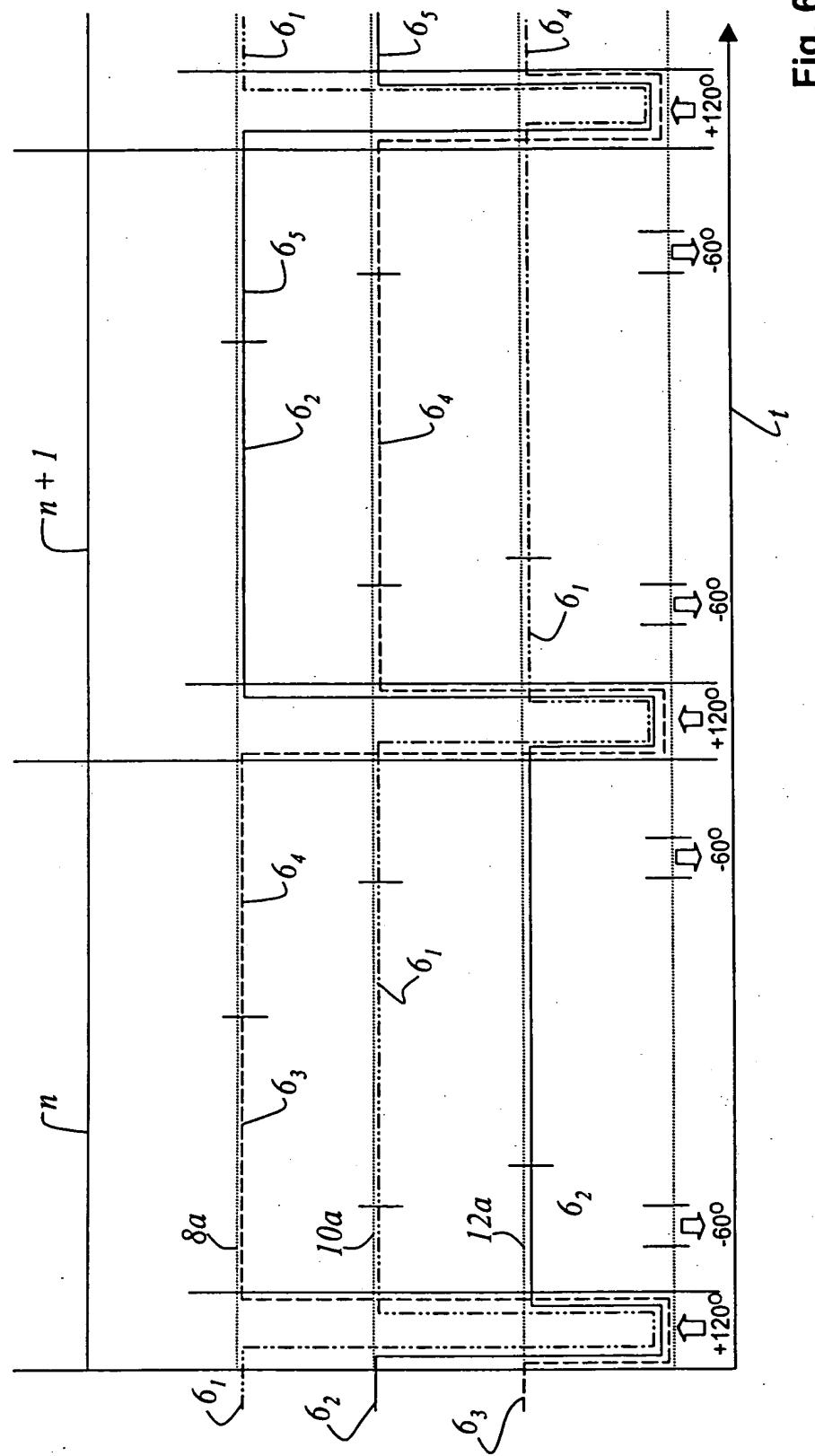


Fig. 6

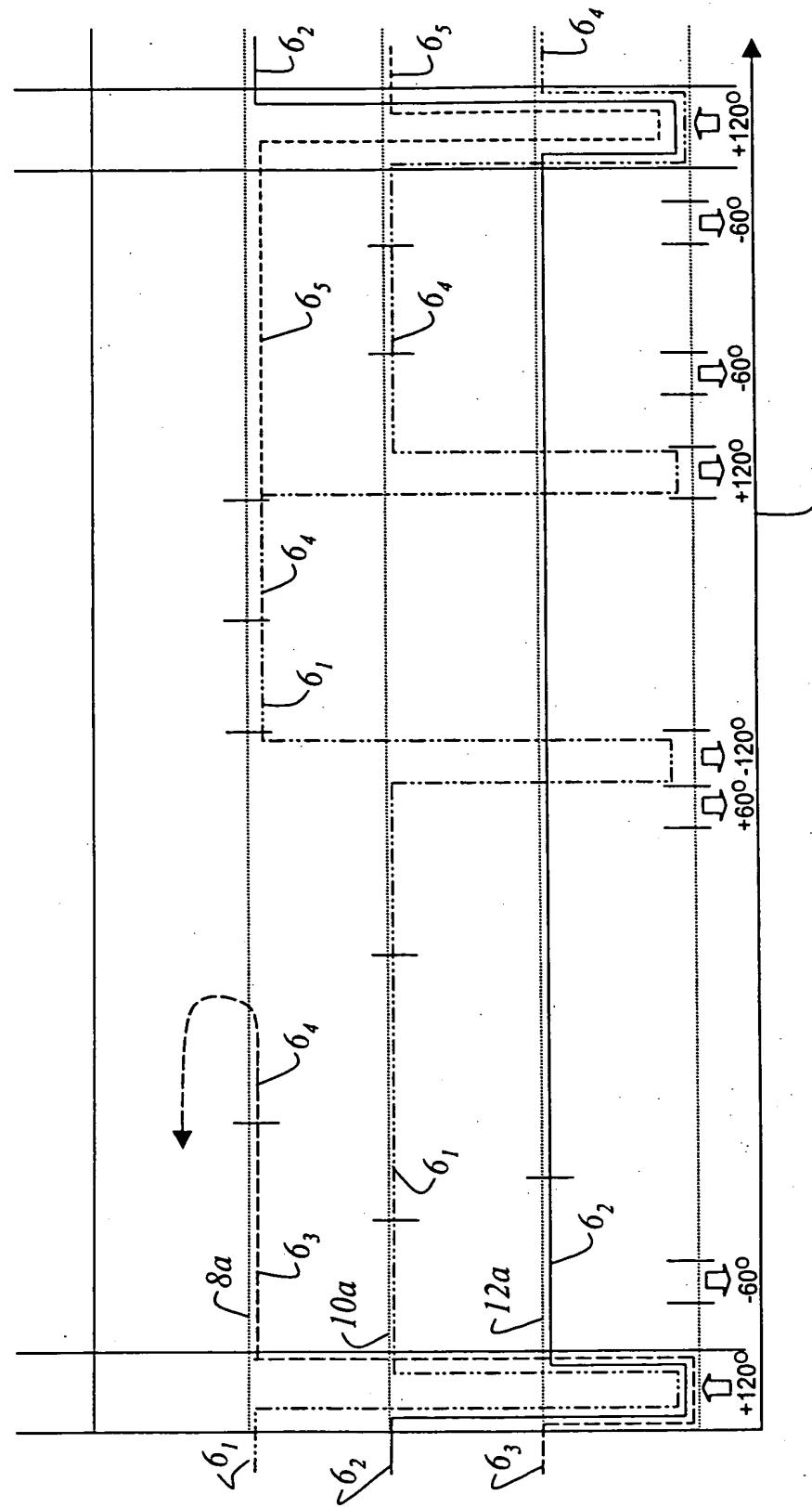


Fig. 7

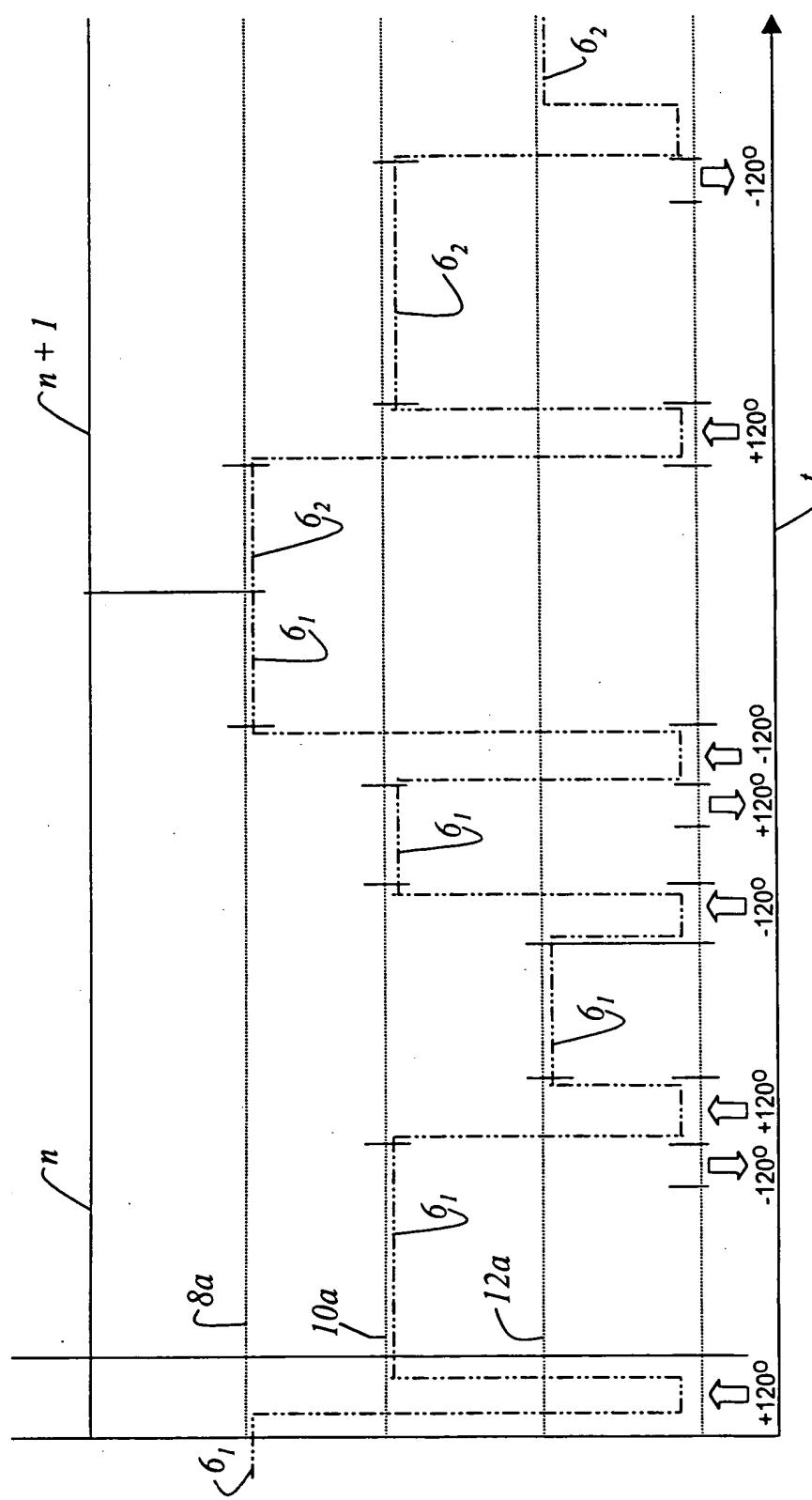


Fig. 8